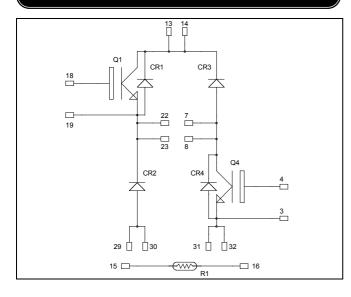
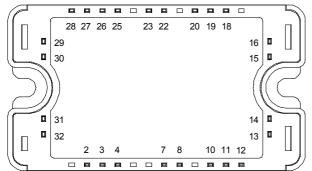


Asymmetrical - Bridge Fast Trench + Field Stop IGBT3 Power Module





All multiple inputs and outputs must be shorted together Example: 13/14 ; 29/30 ; 22/23 ...

### Absolute maximum ratings

#### Symbol Max ratings Parameter Unit Collector - Emitter Breakdown Voltage 1200 V **V**<sub>CES</sub> $T_C = 25^{\circ}C$ 75 Continuous Collector Current $I_{\rm C}$ $T_C = 80^{\circ}C$ 50 А I<sub>CM</sub> Pulsed Collector Current $T_C = 25^{\circ}C$ 100 V<sub>GE</sub> Gate – Emitter Voltage $\pm 20$ V $P_D$ Maximum Power Dissipation $T_C = 25^{\circ}C$ 277 W $T_{J} = 125^{\circ}C$ Reverse Bias Safe Operating Area RBSOA 100A @ 1150V

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

# APTGT50DH120T3G

# $V_{CES} = 1200V$ $I_{C} = 50A$ @ Tc = 80°C

#### Application

- Welding converters
- Switched Mode Power Supplies
- Switched Reluctance Motor Drives

#### Features

- Fast Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive T<sub>C</sub> of V<sub>CEsat</sub>
- RoHS Compliant

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# All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics							
Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				250	μA
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	1.4	1.7	2.1	V
V CE(sat)		$I_C = 50A$ $T_j = 125^{\circ}C$		2.0		v	
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 2mA$		5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

## **Dynamic Characteristics**

T.

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V, V_{CE} = 25V$ f = 1MHz			3600		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				160		pr
Q <sub>G</sub>	Gate charge	$V_{GE}=\pm 15V, I_{C}=50A$ $V_{CE}=600V$			0.5		μC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)			90		
Tr	Rise Time	$V_{GE} = \pm 15V$			30		I
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_C = 50A$ $R_G = 18\Omega$			420		ns
T <sub>f</sub>	Fall Time				70		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C)			90		
Tr	Rise Time		$V_{GE} = \pm 15V$ $V_{Bus} = 600V$ $I_C = 50A$ $R_G = 18\Omega$		50		
T <sub>d(off)</sub>	Turn-off Delay Time				520		ns
$T_{\rm f}$	Fall Time	-			90		I
Eon	Turn-on Switching Energy	$V_{Bus} = \pm 15V$ $V_{Bus} = 600V$ $I_C = 50A$ $R_G = 18\Omega$	$T_{j} = 125^{\circ}C$		5		T
E <sub>off</sub>	Turn-off Switching Energy		$T_j = 125^{\circ}C$		5.5		mJ
I <sub>sc</sub>	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 900V$ $t_p \le 10\mu s$ ; $T_j = 125^{\circ}C$			200		А

# Diode ratings and characteristics (CR2 & CR3)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_j = 25^{\circ}C$			250	μA
			$T_j = 125^{\circ}C$			500	
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		50		A
$V_{\rm F}$	Diode Forward Voltage	$I_F = 50A$	$T_i = 25^{\circ}C$		1.6	2.1	v
• r	Diode I of Hard Younge		$T_{j} = 125^{\circ}C$		1.6		· ·
t <sub>rr</sub>	Reverse Recovery Time	1 50 4	$T_j = 25^{\circ}C$		170		ns
٩r			$T_{j} = 125^{\circ}C$		280		115
Q <sub>rr</sub>	Reverse Recovery Charge	$I_{F} = 50A$ $V_{R} = 600V$ $di/dt = 1900A/\mu s$	$T_j = 25^{\circ}C$		5.6		μC
Qrr			$T_{j} = 125^{\circ}C$		9.9		μυ
Er	Reverse Recovery Energy	J	$T_j = 25^{\circ}C$		2.2		mJ
Ľr			$T_{j} = 125^{\circ}C$		4.1		1113

CR1 & CR4 are IGBT protection diodes only

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# APTGT50DH120T3G

### Thermal and package characteristics

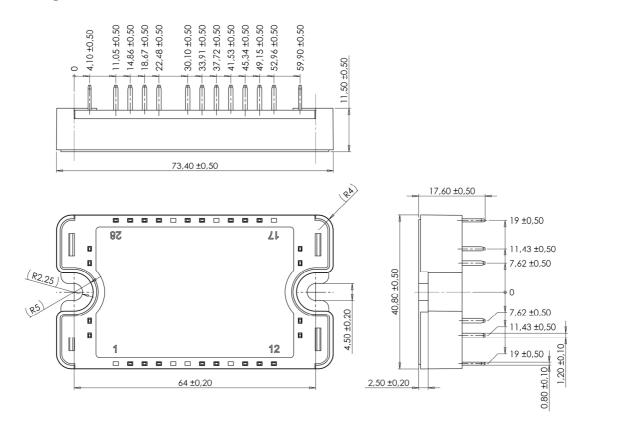
Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance		IGBT			0.45	°C/W
			Diode			0.72	C/ W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T <sub>J</sub>	Operating junction temperature range			-40		150	
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To Heatsink	M5	2		3	N.m
Wt	Package Weight					110	g

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	racteristic		Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C	°C		50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

### SP3 Package outline (dimensions in mm)



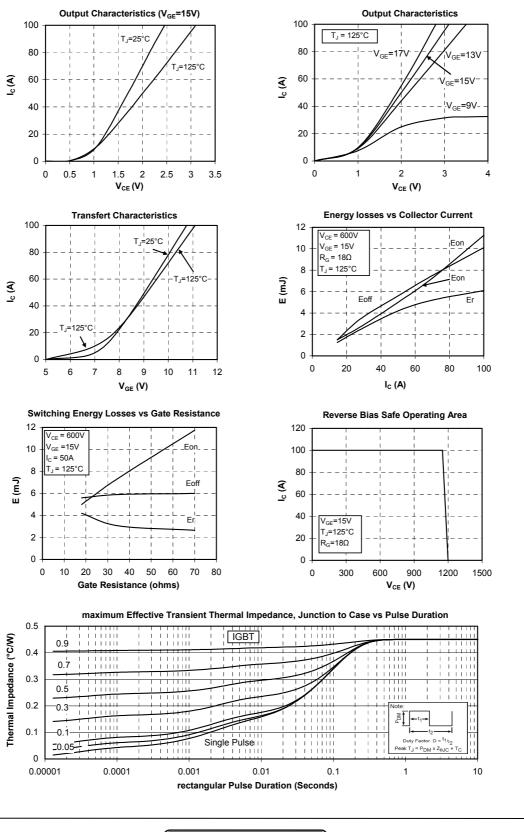
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

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### **Typical Performance Curve**

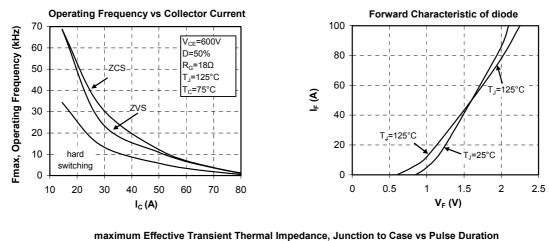


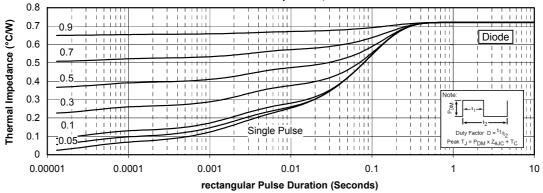
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# APTGT50DH120T3G

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